



Substitute for form 1449A/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT					
(use as many sheets as necessary)					
Sheet	1	of	5	Attorney Docket Number	020921-001930US

U.S. PATENT DOCUMENTS*					
Examiner Initials*	Cite No. ¹	Document Number Number Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1	6,517,249	02-11-2003	Doll	
	2	6,353,219	03-05-2002	Kley	
	3	2002/0007667	01-24-2002	Pohl et al.	
	4	6,340,813	01-22-2002	Tominaga et al.	
	5	6,331,479	01-08-2002	Kley	
	6	6,265,771	07-24-2001	Kley	
	7	6,252,226	06-26-2001	Kley	
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	9	6,229,609	05-08-2001	Muramatsu et al.	
	10	6,144,028	11-07-2000	Kley	
	11	6,101,164	08-08-2000	Kado et al.	
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	13	6,031,756	02-29-2000	Gimszewski et al.	
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	18	5,825,670	10-20-1998	Chernoff et al.	
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	28	5,623,476	04-22-1997	Eguchi	
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	41	5,472,881	12-05-1995	Beebe et al.	

Examiner Signature	Date Considered
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				Filing Date	September 9, 2003
				First Named Inventor	Victor B. Kley
				Art Unit	Unassigned
				Examiner Name	Unassigned
Sheet	2	of	5	Attorney Docket Number	020921-001930US

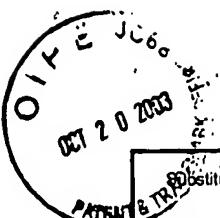
U.S. PATENT DOCUMENTS+					
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	44	5,461,605	10-24-1995	Takimoto	
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Information Disclosure Statement by Applicant (use as many sheets as necessary)				Complete If Known	
Sheet 3 of 5		Application Number		10/659,737	
		Filing Date		September 9, 2003	
		First Named Inventor		Victor B. Kley	
		Art Unit		Unassigned	
		Examiner Name		Unassigned	
		Attorney Docket Number		020921-001930US	

U.S. PATENT DOCUMENTS*				
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	84	5,254,854	10-19-1993	Betzig
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Examiner Signature	Date Considered
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Sheet 4 of 5		Application Number 10/659,737 Filing Date September 9, 2003 First Named Inventor Victor B. Kley Art Unit Unassigned Examiner Name Unassigned Attorney Docket Number 020921-001930US			

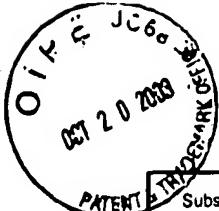
U.S. PATENT DOCUMENTS+					
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	124	4,672,559	06-09-1987	Jansson et al.	
	125	4,604,520	08-05-1986	Pohl	
	126	4,115,806	09-10-1978	Morton	
	127	3,812,288	05-21-1974	Walsh et al.	
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Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³	Number ⁴ Kind Code ⁵ (if known)			
TPW	129	PCT	WO 01/03157	01-11-2001	Kley	11011 37/26
	130	PCT	WO 98/34092 A2	08-06-1998	Kley	
	131	PCT	WO 97/04449	02-06-1997	Kley	11011 27/23
	132	PCT	WO 96/03641 A1	02-08-1996	Kley	11011 23/13
	133	JP	7-105580	04-21-1995	Kley amoto	11011 9/07
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Crossed out references ~ copy
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Sheet	5	of	5	First Named Inventor	Victor B. Kley
				Art Unit	Unassigned
				Examiner Name	Unassigned
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NON PATENT LITERATURE DOCUMENTS					
Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
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	138	BETZIG et al "Near-Field Optics: Microscopy Spectroscopy and Surface Modification Beyond the Diffraction Limit" <i>Science</i> 257:(1992). <i>July pp-189-195</i>			
	139	DAI et al. "Nanotubes as nanoprobes in scanning probe microscopy." <i>Nature</i> 384:147-150 (1996). <i>No. 1, 1996</i>			
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	141	DIAZ et al., An Improved Fabrication Technique for Porous Silicon, <i>Rev. Sci. Instrum.</i> 64 (2), Feb. 1993, pp. 507-509.			
	142	GIVARGIZOV et al "Growth of diamond particles on sharpened silicon tips" <i>Materials Letters</i> 18:(1993). <i>No. 1, 1993 pp-61-64</i>			
	143	GOMYO et al. Effect of Electrochemical Treatments on the Photoluminescence from Porous Silicon, <i>J. Electrochem. Soc.</i> , vol. 139, No. 9, Sep. 1992, pp. L86-L88.			
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Examiner Signature	<i>JKW</i>	Date Considered	<i>5/2/07</i>
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	3	US-5,804,709	09-08-1998	Bougoin et al.	
	4	US-5,289,004	02-22-1994	Okada et al.	

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NON PATENT LITERATURE DOCUMENTS				
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PPM	5	JASCHKE et al. "Deposition of Organic Material by the Tip of a Scanning Force Microscope," Langmuir 11:1061-1064 (1995). Month not given		

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